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| Notice of References Cited | Application/Control No. 09/674,669 | Applicant(s)/Patent Under Reexamination KUNZE, ET AL. |
| | Examiner Dzung C Nguyen | Art Unit 2652 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-5,313,351 | 05-1994 | Lee, Chung-Geu | 360/99.07 |
| | B | US-6,151,279 | 11-2000 | Ikeda et al. | 369/30.98 |
| | C | US-6,052,356 | 04-2000 | Fujimoto et al. | 369/192 |
| | D | US-6,044,054 | 03-2000 | Shiomi, Tetsuhiro | 369/77.1 |
| | E | US-6,370,100 | 04-2002 | Koshino et al. | 369/77.1 |
| | F | US-4,672,478 | 06-1987 | Takai et al. | 360/93 |
| | G | US-5,377,061 | 12-1994 | Yoshimura, Toshio | 360/96.5 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|----------------|----------------|
| * | N | 0905688 A1 | 06-1999 | EPO | Yuji et al | |
| * | O | 0926667 A2 | 03-1999 | EPO | Mitsuo et al | |
| * | P | 0332171 A2 | 09-1989 | EPO | Yukizasu et al | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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